

## N - CHANNEL ENHANCEMENT MODE POWER MOS TRANSISTOR

TYPE	V <sub>DSS</sub>	R <sub>DS(on)</sub>	I <sub>D</sub>
BUZ32	200 V	0.4 Ω	9.5 A

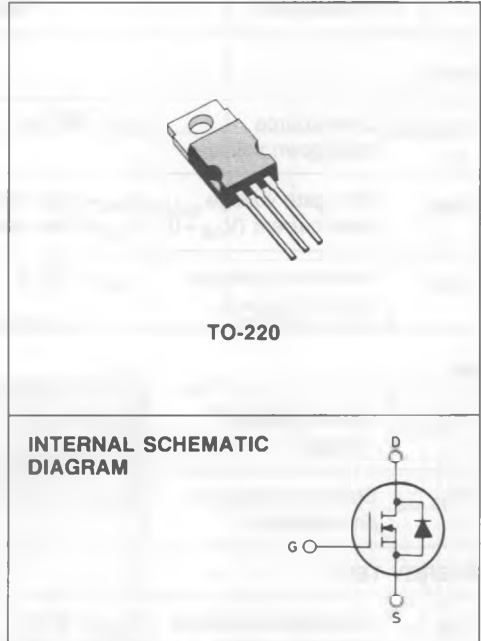
- 200 VOLTS FOR TELECOMS APPLICATIONS
- HIGH CURRENT - FOR PULSED LASER DRIVES
- RATED FOR UNCLAMPED INDUCTIVE SWITCHING (ENERGY TEST) ♦
- ULTRA FAST SWITCHING
- EASY DRIVE - FOR REDUCED COST AND SIZE

**INDUSTRIAL APPLICATIONS:**

- SWITCHING MODE POWER SUPPLIES
- MOTOR CONTROLS FOR ROBOTICS

N-channel enhancement mode POWER MOS field effect transistor. Easy drive and very fast switching times make this POWER MOS transistor ideal for high speed switching applications.

Typical uses include robotics, laser diode drives, UPS, SMPS, DC/DC, DC switch for telecomms and electric vehicle drives.


**ABSOLUTE MAXIMUM RATINGS**

V <sub>DS</sub>	Drain-source voltage (V <sub>GS</sub> = 0)	200	V
V <sub>DGR</sub>	Drain-gate voltage (R <sub>GS</sub> = 20 KΩ)	200	V
V <sub>GS</sub>	Gate-source voltage	± 20	V
I <sub>D</sub>	Drain current (continuous) T <sub>c</sub> = 25°C	9.5	A
I <sub>DM</sub>	Drain current (pulsed)	38	A
P <sub>tot</sub>	Total dissipation at T <sub>c</sub> < 25°C	75	W
T <sub>stg</sub>	Storage temperature	- 55 to 150	°C
T <sub>j</sub>	Max. operating junction temperature	150	°C
	DIN humidity category (DIN 40040)	E	
	IEC climatic category (DIN IEC 68-1)	55/150/56	

♦ Introduced in 1989 week 1

**THERMAL DATA**

$R_{thj - case}$	Thermal resistance junction-case	max	1.67	°C/W
$R_{thj - amb}$	Thermal resistance junction-ambient	max	75	°C/W

**ELECTRICAL CHARACTERISTICS** ( $T_j = 25^\circ\text{C}$  unless otherwise specified)

Parameters	Test Conditions	Min.	Typ.	Max.	Unit
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**OFF**

$V_{(BR) DSS}$	Drain-source breakdown voltage	$I_D = 250 \mu\text{A}$	$V_{GS} = 0$	200		V
$I_{DSS}$	Zero gate voltage drain current ( $V_{GS} = 0$ )	$V_{DS} = \text{Max Rating}$	$V_{DS} = \text{Max Rating}$			250 $\mu\text{A}$ 1000 $\mu\text{A}$
$I_{GSS}$	Gate-body leakage current ( $V_{DS} = 0$ )	$V_{GS} = \pm 20 \text{ V}$				$\pm 100$ nA

**ON**

$V_{GS(th)}$	Gate threshold voltage	$V_{DS} = V_{GS}$	$I_D = 1 \text{ mA}$	2.1		4 V
$R_{DS(on)}$	Static drain-source on resistance	$V_{GS} = 10 \text{ V}$	$I_D = 4.5 \text{ A}$			0.4 $\Omega$

**ENERGY TEST**

$I_{UIS}$	Unclamped inductive switching current (single pulse)	$V_{DD} = 30 \text{ V}$ starting $T_j = 25^\circ\text{C}$	$L = 100 \mu\text{H}$	9.5		A
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**DYNAMIC**

$g_{fs}$	Forward transconductance	$V_{DS} = 25 \text{ V}$	$I_D = 4.5 \text{ A}$	2.2		mho
$C_{iss}$	Input capacitance	$V_{DS} = 25 \text{ V}$ $V_{GS} = 0$	$f = 1 \text{ MHz}$			2000 pF
$C_{oss}$	Output capacitance					400 pF
$C_{rss}$	Reverse transfer capacitance					120 pF

**SWITCHING**

$t_{d(on)}$	Turn-on time	$V_{DD} = 30 \text{ V}$ $R_{GS} = 50 \Omega$	$I_D = 2.9 \text{ A}$ $V_{GS} = 10 \text{ V}$			45 ns
$t_r$	Rise time					60 ns
$t_{d(off)}$	Turn-off delay time					140 ns
$t_f$	Fall time					80 ns

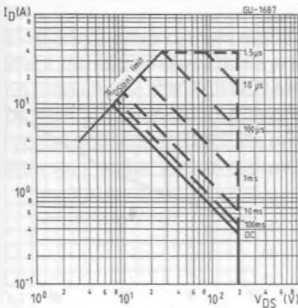
ELECTRICAL CHARACTERISTICS (Continued)

Parameters		Test Conditions		Min.	Typ.	Max.	Unit
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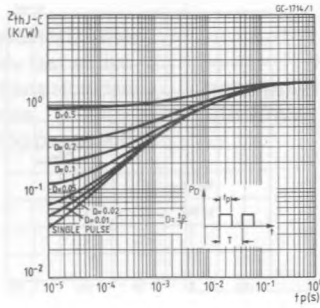
SOURCE DRAIN DIODE

$I_{SD}$	Source-drain current	$T_c = 25^\circ\text{C}$				9.5	A
$I_{SDM}$	Source-drain current (pulsed)					38	A
$V_{SD}$	Forward on voltage	$I_{SD} = 19\text{ A}$	$V_{GS} = 0$			1.7	V
$t_{rr}$	Reverse recovery time				400		ns
$Q_{rr}$	Reverse recovered charge	$I_{SD} = 9.5\text{ A}$	$di/dt = 100\text{A}/\mu\text{s}$		6		$\mu\text{C}$

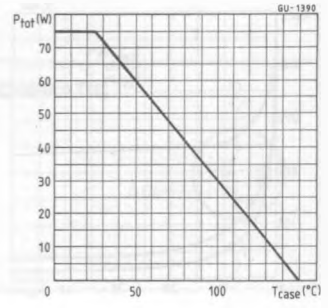
Safe operating areas



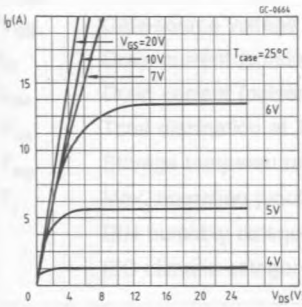
Thermal impedance



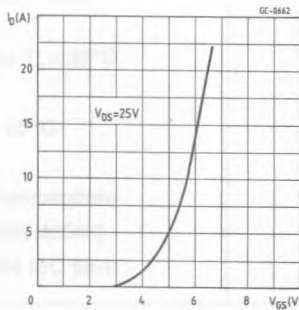
Derating curve



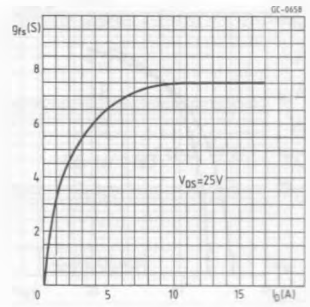
Output characteristics



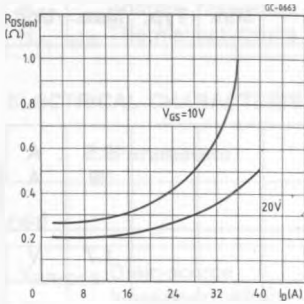
Transfer characteristics



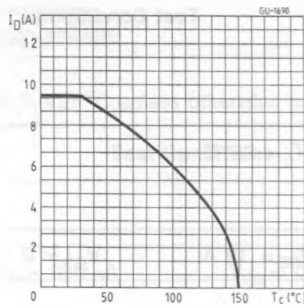
Transconductance



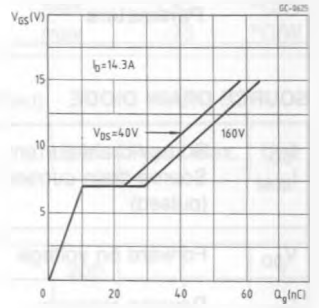
**Static drain-source on resistance**



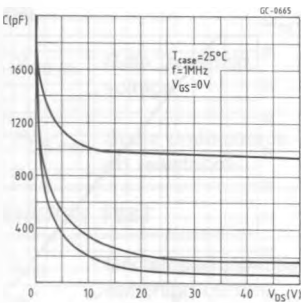
**Maximum drain current vs temperature**



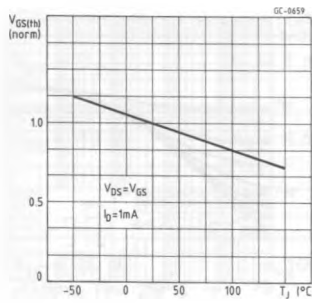
**Gate charge vs gate-source voltage**



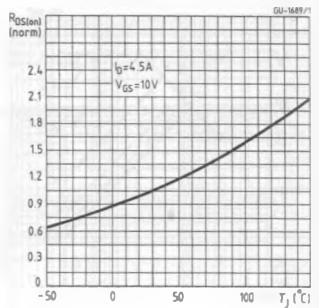
**Capacitance variation**



**Gate threshold voltage vs temperature**



**Drain-source on resistance vs temperature**



**Source-drain diode forward characteristics**

